



**International
Standard**

ISO/IEC 5152

**Information technology —
Biometric performance
estimation methodologies using
statistical models**

*Technologies de l'information — Méthodologies d'estimation des
performances biométriques à l'aide de modèles statistiques*

**First edition
2024-07**

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Published in Switzerland

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Foreword

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This document was prepared by Joint Technical Committee ISO/IEC JTC 1, *Information technology*, Subcommittee SC 37, *Biometrics*.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html and www.iec.ch/national-committees.

Introduction

This document provides a methodology for measuring the accuracy of biometric verification systems based on the statistics categorized as the extreme value theory.^[1] The methodology is particularly useful when estimating the false match rate with a relatively small sample set. The methodology is an alternative to empirical accuracy measurement.

In order to measure the false match rate of biometric verification systems, evaluators need to prepare a dataset with a sufficiently large number of non-mated attempts in order to observe a sufficient number of false match cases for a reliable estimation of the false match rate. For highly accurate systems the quantity of attempts required to test the false match rate is likely to be extremely large. As performance of biometric verification systems improves dramatically, acquiring representative data of non-mated attempts in sufficient quantity becomes increasingly difficult in terms of the time, cost and practicality of creating datasets. Policy considerations that apply to biometric data collection and use can pose further constraints.

If no false match case is found within the evaluation samples, metrics based on statistics known as “the rule of three” (as is defined in ISO/IEC 19795-1) are widely used in the biometric industry. However, the rule of 3 is only applicable when no false match case is observed within the tested sample set and do not give any indication of the accuracy and confidence levels expected if more than zero false matches were tested. Only if at least 30 false matches were observed, the “rule of thirty” applies, i.e. the true error rate is with 90 % confidence within ± 30 % of the observed error rate.

In this document, two major statistical methods are introduced to estimate the false match rate with a relatively small number of samples. Both methods are widely used in a variety of industries including civil engineering, meteorology, hydrology and financial engineering. Both methods are proven to be highly reliable techniques to estimate the probability of the occurrence of rare, extreme events such as maximum wind velocity or tsunami heights. These statistical methods are applied to similarly rare events of false match cases in biometrics and used to estimate the probability of occurrence of such cases if a larger non-mated sample set is not available. The estimated false match rate is available in the form of cumulative distribution function (CDF) and its interval of confidence.

This document defines procedures for extrapolating performance metrics in technology evaluations. These procedures can also be applied in scenario evaluations and operational evaluations if comparison scores are obtained. This document defines the methodology to be used by evaluators to reliably estimate the false match rate in case of a limited number of false match cases or even no false match case at all. This document does not address certification or conformance.